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| <b>Search Notes</b><br> | <b>Application/Control No.</b><br>10073599 | <b>Applicant(s)/Patent Under Reexamination</b><br>DAIGO ET AL. |
|  | <b>Examiner</b><br>LUONG T NGUYEN          | <b>Art Unit</b><br>2622  |

| SEARCHED |          |      |          |
|----------|----------|------|----------|
| Class    | Subclass | Date | Examiner |
|          |          |      |          |

| SEARCH NOTES  |         |          |
|---|---------|----------|
| Search Notes  | Date    | Examiner |
| 725/105; 348/231.99,231.3,231.6,207.1,207.99,552 (text search only)   | 3/4/06  | LTN      |
| EAST (USPAT; US_PGPUB; JPO: EPO; DERWENT; IBM_TDB) see search history | 3/4/06  | LTN      |
| updated EAST, using previously cited references                       | 3/30/07 | LTN      |
| updated EAST, using previously cited references                       | 11/7/07 | LTN      |
| updated EAST, using previously cited references                       | 5/11/08 | LTN      |

| INTERFERENCE SEARCH |          |      |          |
|---------------------|----------|------|----------|
| Class               | Subclass | Date | Examiner |
|                     |          |      |          |